

## CLAIM AMENDMENTS

Please amend claims 1, 10, and 20 as follows.

1. (Currently Amended) An apparatus, comprising:
  - a single-crystal silicon active region fully or partially transparent to an optical signal;
  - a bulk silicon inactive region; and
  - a membrane coupling the single-crystal silicon active region to the bulk silicon inactive region,the single-crystal silicon active region doped to make it electrically ~~conductive~~ conductive in order to thermally tune the single-crystal silicon active region to pass a specific wavelength in response to the received optical signal.
2. (Original) The apparatus of claim 1, wherein the single-crystal silicon active region includes a p-type material dopant.
3. (Original) The apparatus of claim 2, wherein the single-crystal silicon active region includes a boron (B) dopant.
4. (Original) The apparatus of claim 1, wherein the single-crystal silicon active region includes an n-type material dopant.
5. (Original) The apparatus of claim 4, wherein the single-crystal silicon active region includes a phosphorous (P) dopant.
6. (Original) The apparatus of claim 4, wherein the single-crystal silicon active region includes an arsenic (As) dopant.

7. (Original) The apparatus of claim 1, wherein the membrane is a silicon nitride (SiN) membrane, with varying atomic ratios of silicon and nitrogen.
8. (Original) The apparatus of claim 1, wherein the membrane is a silicon oxide (SiO<sub>2</sub>) membrane.
9. (Original) The apparatus of claim 1, further comprising a temperature sensor formed on the single-crystal silicon active region.
10. (Currently Amended) The apparatus of claim 1 ~~[[10]]~~, further comprising a platinum temperature sensor formed on the single-crystal silicon active region.
11. (Original) The apparatus of claim 1, further comprising gold bond pads mounted to the perimeter of the single-crystal silicon active region.
12. (Original) The apparatus of claim 1, further comprising bond pads mounted to the top of the single-crystal silicon active region.
13. (Original) The apparatus of claim 1, further comprising bond pads mounted to the bottom of the single-crystal silicon active region.
14. (Original) A system, comprising:
  - a transponder having a wavelength-selective element, the wavelength-selective element having a single-crystal silicon active region adapted to receive an optical signal, a bulk silicon inactive region, and a membrane coupling the single-crystal silicon active region to the bulk silicon inactive region, the single-crystal silicon active region doped to make it both electrically conductive and thermally conductive the single-crystal silicon active region coupled so as to receive a current to thermally tune the single-crystal silicon active region to pass a wavelength in response to the received optical signal; and
  - an erbium-doped fiber amplifier (EDFA) coupled to the transponder.

15. (Original) The system of claim 14, further comprising a multiplexer coupled to the EDFA.
16. (Original) The system of claim 15, further comprising an add-drop multiplexer coupled to the EDFA.
17. (Original) A method, comprising:  
adjusting resistivity of a doped silicon etalon ; and  
applying a current to the doped silicon etalon to thermally tune the doped silicon etalon to select a wavelength in response to an incident optical signal.
18. (Original) The method of claim 17, further comprising applying a second current to the doped silicon etalon to thermally tune the doped silicon etalon to select a second wavelength.
19. (Original) The method of claim 18, further comprising sensing the temperature of the doped silicon etalon.
20. (Currently Amended) An apparatus, comprising:  
a laser having:  
a cavity; and  
a doped silicon etalon positioned in the cavity, wherein the doped silicon etalon is to receive a current to thermally tune the doped silicon etalon.
21. (Original) The apparatus of claim 20, wherein the doped silicon etalon includes a p-type material dopant.
22. (Original) The apparatus of claim 21, wherein the doped silicon etalon includes a boron (B) dopant.
23. (Original) The apparatus of claim 20, wherein the doped silicon etalon includes an n-type material dopant.